



February 2010

# Single-Channel: 6N137M, HCPL2601M, HCPL2611M Dual-Channel: HCPL2630M, HCPL2631M (Preliminary) High Speed 10MBit/s Logic Gate Optocouplers

### Features

- Very high speed 10 MBit/s
- Superior CMR 10 kV/µs
- Fan-out of 8 over -40°C to +85°C
- Logic gate output
- Strobable output
- Wired OR-open collector
- U.L. recognized (File # E90700, Vol. 2)

# Applications

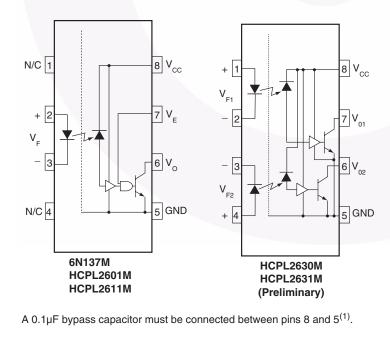
- Ground loop elimination
- LSTTL to TTL, LSTTL or 5-volt CMOS
- Line receiver, data transmission
- Data multiplexing
- Switching power supplies
- Pulse transformer replacement
- Computer-peripheral interface

# Description

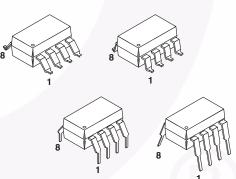
The 6N137M, HCPL2601M, HCPL2611M single-channel and HCPL2630M, HCPL2631M dual-channel optocouplers consist of a 850 nm AlGaAS LED, optically coupled to a very high speed integrated photo-detector logic gate with a strobable output. This output features an open collector, thereby permitting wired OR outputs. The switching parameters are guaranteed over the temperature range of -40°C to +85°C. A maximum input signal of 5mA will provide a minimum output sink current of 13mA (fan out of 8).

An internal noise shield provides superior common mode rejection of typically  $10kV/\mu s$ . The HCPL2601M and HCPL2631M has a minimum CMR of  $5kV/\mu s$ . The HCPL2611M has a minimum CMR of  $10kV/\mu s$ .

# Schematics



Package Outlines



### Truth Table (Positive Logic)

Enable	Output				
Н	L				
Н	Н				
L	Н				
L	Н				
NC	L				
NC	Н				
	H H L L NC				

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# Absolute Maximum Ratings ( $T_A = 25^{\circ}C$ unless otherwise specified)

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Param	Value	Units	
T <sub>STG</sub>	Storage Temperature		-40 to +125	°C
T <sub>OPR</sub>	Operating Temperature		-40 to +100	°C
T <sub>SOL</sub>	Lead Solder Temperature		260 for 10 sec	°C
EMITTER				
١ <sub>F</sub>	DC/Average Forward	Single Channel	50	mA
	Input Current	Dual Channel (Each Channel)	30	
V <sub>E</sub>	Enable Input Voltage Not to Exceed V <sub>CC</sub> by more than 500mV	Single Channel	5.5	V
V <sub>R</sub>	Reverse Input Voltage	Each Channel	5.0	V
PI	Power Dissipation	Single Channel	100	mW
		Dual Channel (Each Channel)	45	
DETECTOR			-!	
V <sub>CC</sub> (1 minute max)	Supply Voltage		7.0	V
Ι <sub>Ο</sub>	Output Current	Single Channel	50	mA
		Dual Channel (Each Channel)	50	
Vo	Output Voltage Each Channel		7.0	V
Po	Collector Output Single Channel		85	mW
	Power Dissipation	Dual Channel (Each Channel)	60	

### **Recommended Operating Conditions**

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Min.	Max.	Units
IFL	Input Current, Low Level	0	250	μA
I <sub>FH</sub>	Input Current, High Level	*6.3	15	mA
V <sub>CC</sub>	Supply Voltage, Output	4.5	5.5	V
V <sub>EL</sub>	Enable Voltage, Low Level	0	0.8	V
V <sub>EH</sub>	Enable Voltage, High Level	2.0	V <sub>CC</sub>	V
T <sub>A</sub>	Low Level Supply Current	-40	+85	°C
Ν	Fan Out (TTL load)		8	

\*6.3mA is a guard banded value which allows for at least 20% CTR degradation. Initial input current threshold value is 5.0mA or less.

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### **Individual Component Characteristics**

Symbol	Parameter	Test Condit	ions	Min.	Тур.*	Max.	Unit
EMITTER				1	1	<u> </u>	!
V <sub>F</sub>	Input Forward Voltage	I <sub>F</sub> = 10mA				1.8	V
			$T_A = 25^{\circ}C$		1.4	1.75	1
B <sub>VR</sub>	Input Reverse Breakdown Voltage	I <sub>R</sub> = 10μΑ		5.0			V
C <sub>IN</sub>	Input Capacitance	V <sub>F</sub> = 0, f = 1MHz			60		pF
$\Delta V_{F} / \Delta T_{A}$	Input Diode Temperature Coefficient	I <sub>F</sub> = 10mA			-1.4		mV/°C
DETECTOR	ł	•			•		
I <sub>CCH</sub>	High Level Supply Current	$V_{\rm CC} = 5.5 V, I_{\rm F} = 0 {\rm mA},$	Single Channel		6	10	mA
		$V_{E} = 0.5V$	Dual Channel	6	10	15	
I <sub>CCL</sub>	Low Level Supply Current	Single Channel	V <sub>CC</sub> = 5.5V, I <sub>F</sub> = 10mA		8	13	mA
		Dual Channel	$V_{E} = 0.5V$		14	21	1
I <sub>EL</sub>	Low Level Enable Current	$V_{CC} = 5.5 V, V_E = 0.5 V$			-0.7	-1.6	mA
I <sub>EH</sub>	High Level Enable Current	$V_{CC} = 5.5 V, V_E = 2.0 V$			-0.5	-1.6	mA
V <sub>EH</sub>	High Level Enable Voltage	V <sub>CC</sub> = 5.5V, I <sub>F</sub> = 10mA		2.0			V
V <sub>EL</sub>	Low Level Enable Voltage	$V_{CC} = 5.5V, I_F = 10mA^{(3)}$				0.8	V

### Switching Characteristics ( $T_A = -40^{\circ}C$ to $+85^{\circ}C$ , $V_{CC} = 5V$ , $I_F = 7.5mA$ unless otherwise specified)

Symbol	AC Characteristics	Test Co	onditions	Min.	Тур.*	Max.	Unit
T <sub>PLH</sub>	Propagation Delay Time to Output HIGH Level	$R_L = 350\Omega,$ $C_L = 15pF^{(4)}$ (Fig. 12)	$T_A = 25^{\circ}C$	20	40	75 100	ns
T <sub>PHL</sub>	Propagation Delay Time to Output LOW Level	$T_A = 25^{\circ}C^{(5)}$ $R_L = 350\Omega, C_L = 15pF$ (	Fig. 12)	25	40	75 100	ns
IT <sub>PHL</sub> -T <sub>PLH</sub> I	Pulse Width Distortion	$(R_L = 350\Omega, C_L = 15pF)$	(Fig. 12)		1	35	ns
t <sub>r</sub>	Output Rise Time (10–90%)	$R_L = 350\Omega, C_L = 15pF^{(6)}$	<sup>i)</sup> (Fig. 12)		30		ns
t <sub>f</sub>	Output Rise Time (90–10%)	$R_L = 350\Omega, C_L = 15pF^{(7)}$	$R_L = 350\Omega$ , $C_L = 15pF^{(7)}$ (Fig. 12)				ns
t <sub>ELH</sub>	Enable Propagation Delay Time to Output HIGH Level	I <sub>F</sub> = 7.5mA, V <sub>EH</sub> = 3.5V, R <sub>L</sub> = 350Ω, C <sub>L</sub> = 15pF <sup>(8)</sup> (Fig. 13)			15		ns
t <sub>EHL</sub>	Enable Propagation Delay Time to Output LOW Level	I <sub>F</sub> = 7.5mA, V <sub>EH</sub> = 3.5V, R <sub>L</sub> = 350Ω, C <sub>L</sub> = 15pF <sup>(9)</sup> (Fig. 13)			15	E	ns
ICM <sub>H</sub> I	Common Mode	$T_A = 25^{\circ}C,  V_{CM}  = 50V$	6N137M, HCPL2630M		10,000		V/µs
	Transient Immunity (at Output HIGH Level)	$      (\text{Peak}), I_F = 0\text{mA}, \\ V_{OH} (\text{Min.}) = 2.0\text{V}, \\ R_L = 350\Omega^{(10)} \text{ (Fig. 14)} $	HCPL2601M, HCPL2631M	5000	10,000		
		$ V_{CM}  = 400V$	HCPL2611M	10,000	15,000		V/µs
ICMLI	Common Mode	$R_L = 350\Omega, I_F = 7.5mA,$	6N137M, HCPL2630M		10,000		1
	Transient Immunity (at Output LOW Level)	$V_{OL}$ (Max.) = 0.8V, $T_A = 25^{\circ}C^{(11)}$ (Fig. 14)	HCPL2601M, HCPL2631M	5000	10,000		
		V <sub>CM</sub>   = 400V	HCPL2611M	10,000	15,000		1

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### Electrical Characteristics (Continued)

Symbol	DC Characteristics	Test Conditions	Min.	Тур.*	Max.	Unit
I <sub>ОН</sub>	HIGH Level Output Current	$V_{CC} = 5.5V, V_O = 5.5V,$ $I_F = 250\mu A, V_E = 2.0V^{(2)}$			100	μA
V <sub>OL</sub>	LOW Level Output Current	$V_{CC} = 5.5V, I_F = 5mA, V_E = 2.0V,$ $I_{CL} = 13mA^{(2)}$		0.4	0.6	V
I <sub>FT</sub>	Input Threshold Current	$V_{CC} = 5.5$ V, $V_{O} = 0.6$ V, $V_{E} = 2.0$ V, $I_{OL} = 13$ mA		3	5	mA

Transfer Characteristics (T<sub>A</sub> = -40 to +85°C unless otherwise specified)

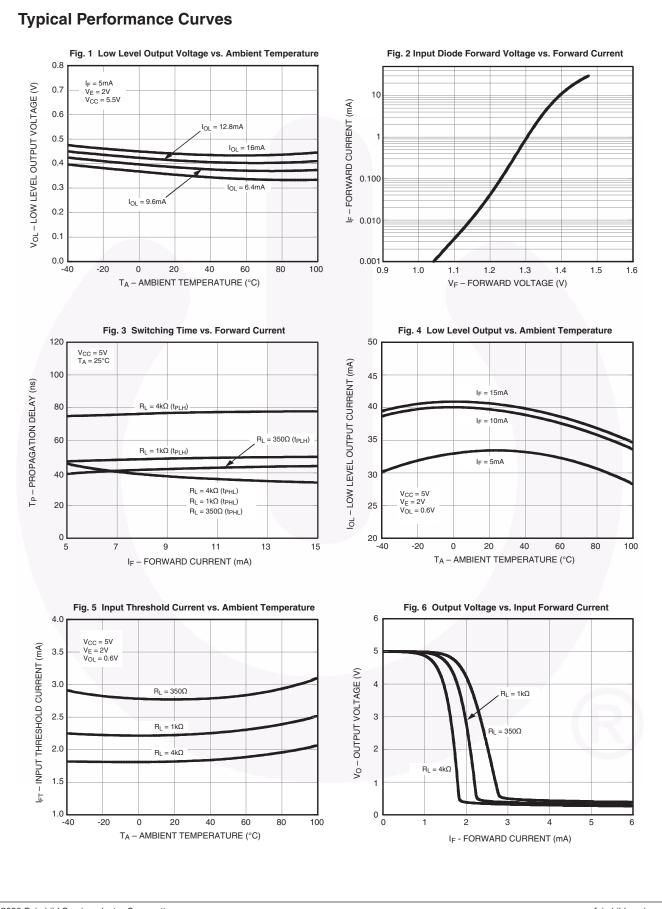
### Isolation Characteristics (T<sub>A</sub> = -40°C to +85°C unless otherwise specified.)

Symbol	Characteristics	Test Conditions	Min.	Тур.*	Max.	Unit
I <sub>I-O</sub>	Input-Output Insulation Leakage Current	$\label{eq:transform} \begin{array}{l} \mbox{Relative humidity} = 45\%, \\ \mbox{T}_A = 25^\circ\mbox{C}, \ t = 5\mbox{s}, \\ \mbox{V}_{I\text{-}O} = 3000 \ \mbox{VDC}^{(12)} \end{array}$			1.0*	μA
V <sub>ISO</sub>	Withstand Insulation Test Voltage	$\begin{array}{l} RH < 50\%,  T_A = 25^{\circ}C, \\ I_{I-O} \leq 10 \mu A,  t = 1  \mbox{min.}^{(12)} \end{array}$	5000			V <sub>RMS</sub>
R <sub>I-O</sub>	Resistance (Input to Output)	$V_{I-O} = 500V^{(12)}$		10 <sup>11</sup>		Ω
C <sub>I-O</sub>	Capacitance (Input to Output)	$f = 1 MHz^{(12)}$		1		pF

\*All Typicals at  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}C$ 

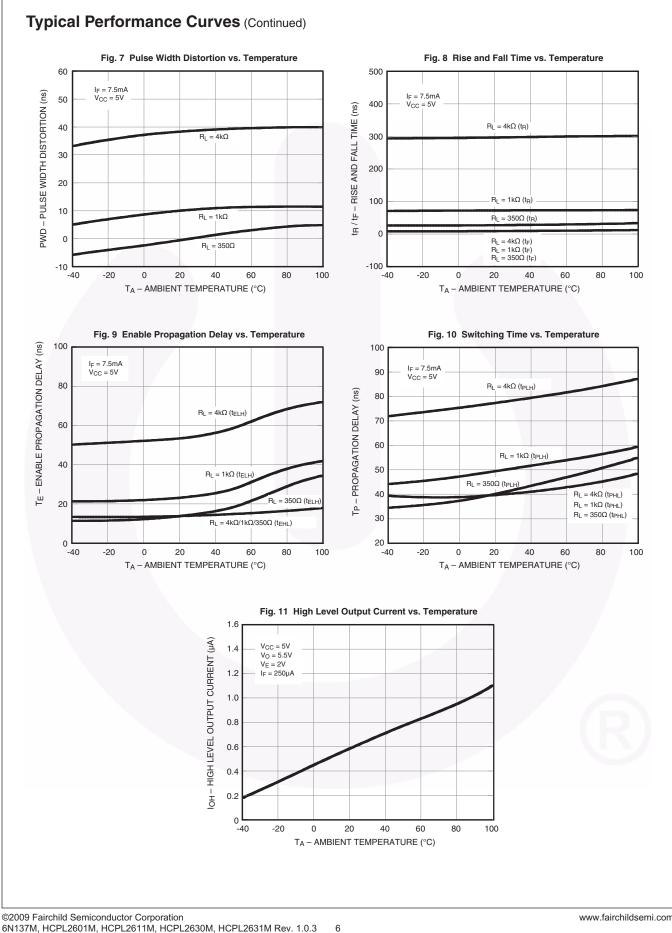
#### Notes:

- The V<sub>CC</sub> supply to each optoisolator must be bypassed by a 0.1µF capacitor or larger. This can be either a ceramic
  or solid tantalum capacitor with good high frequency characteristic and should be connected as close as possible
  to the package V<sub>CC</sub> and GND pins of each device.
- 2. Each channel.
- 3. Enable Input No pull up resistor required as the device has an internal pull up resistor.
- t<sub>PLH</sub> Propagation delay is measured from the 3.75mA level on the HIGH to LOW transition of the input current pulse to the 1.5 V level on the LOW to HIGH transition of the output voltage pulse.
- t<sub>PHL</sub> Propagation delay is measured from the 3.75mA level on the LOW to HIGH transition of the input current pulse to the 1.5 V level on the HIGH to LOW transition of the output voltage pulse.
- 6.  $t_r$  Rise time is measured from the 90% to the 10% levels on the LOW to HIGH transition of the output pulse.
- 7.  $t_f$  Fall time is measured from the 10% to the 90% levels on the HIGH to LOW transition of the output pulse.
- 8. t<sub>ELH</sub> Enable input propagation delay is measured from the 1.5V level on the HIGH to LOW transition of the input voltage pulse to the 1.5V level on the LOW to HIGH transition of the output voltage pulse.
- 9. t<sub>EHL</sub> Enable input propagation delay is measured from the 1.5V level on the LOW to HIGH transition of the input voltage pulse to the 1.5V level on the HIGH to LOW transition of the output voltage pulse.
- CM<sub>H</sub> The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the HIGH state (i.e., V<sub>OUT</sub> > 2.0V). Measured in volts per microsecond (V/μs).
- CM<sub>L</sub> The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the LOW output state (i.e., V<sub>OUT</sub> < 0.8V). Measured in volts per microsecond (V/μs).</li>
- 12. Device considered a two-terminal device: Pins 1, 2, 3 and 4 shorted together, and Pins 5, 6, 7 and 8 shorted together.

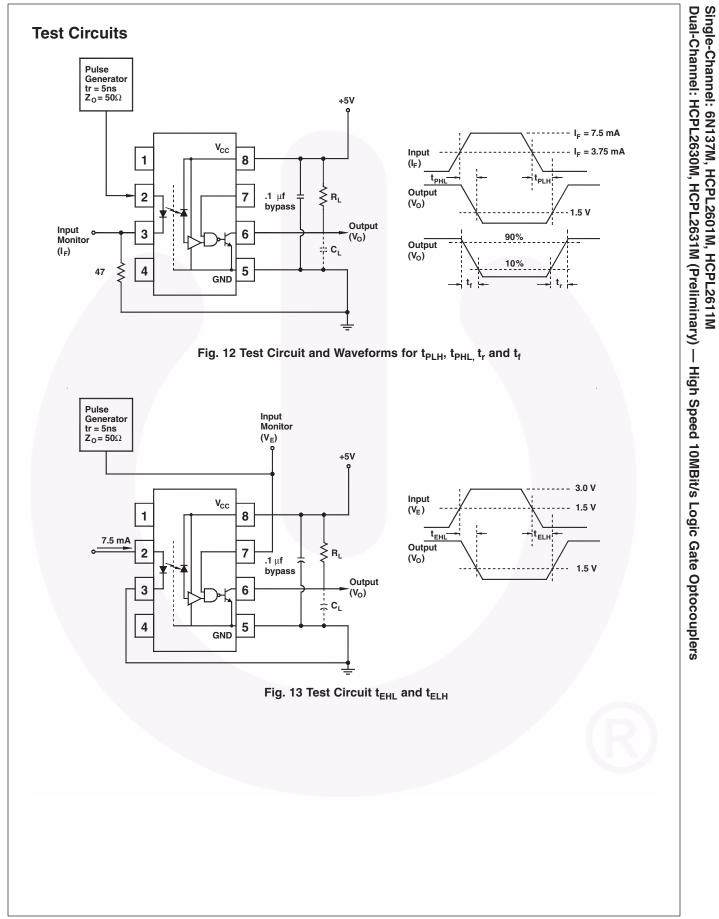


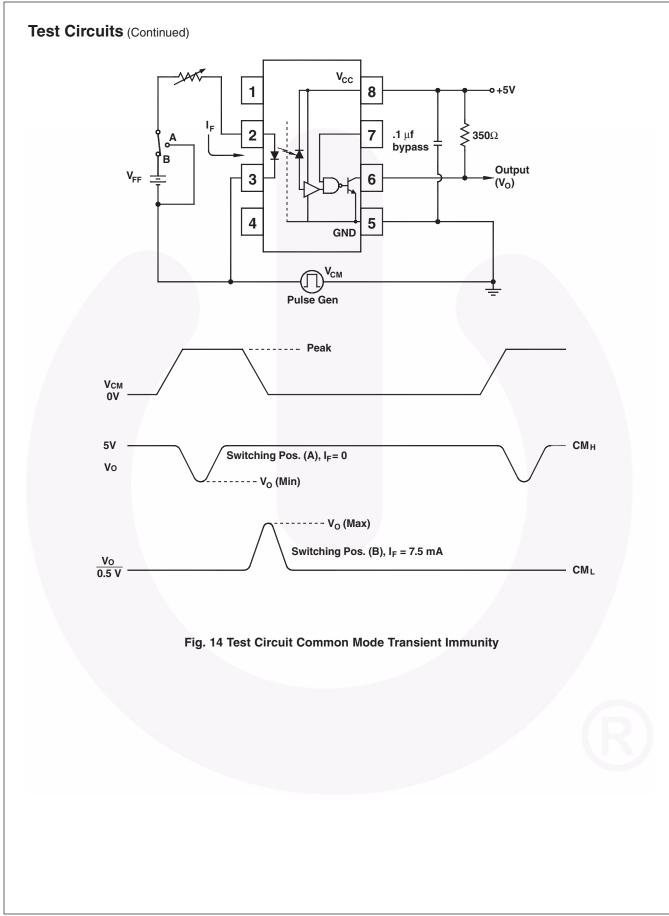
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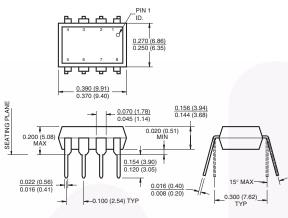




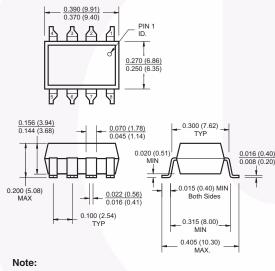
Single-Channel: 6N137M, HCPL2601M, HCPL2611M Dual-Channel: HCPL2630M, HCPL2631M (Preliminary) — High Speed 10MBit/s Logic Gate Optocouplers

### **Package Dimensions**

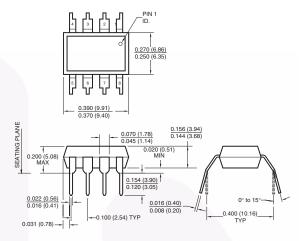
### **Through Hole**

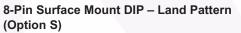


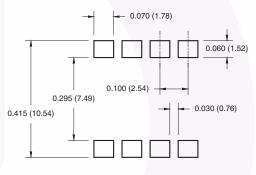
Surface Mount - 0.3" Lead Spacing (Option S)



0.4" Lead Spacing (Option TV) (Pending)







All dimensions are in inches (millimeters)

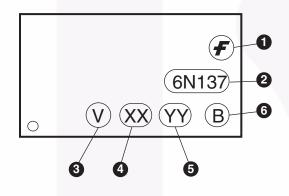
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# **Ordering Information**

Option	Example Part Number	Description
No Suffix	6N137M	Standard Through Hole Device, 50 pcs per tube
S	6N137SM	Surface Mount Lead Bend
SD	6N137SDM	Surface Mount; Tape and Reel
V	6N137VM	IEC60747-5-2 approval pending (VDE)
TV	6N137TVM	IEC60747-5-2 approval pending (VDE), 0.4" lead spacing
SV	6N137SVM	IEC60747-5-2 approval pending (VDE), surface mount
SDV	6N137SDVM	IEC60747-5-2 approval pending (VDE), surface mount, tape and reel

# **Marking Information**

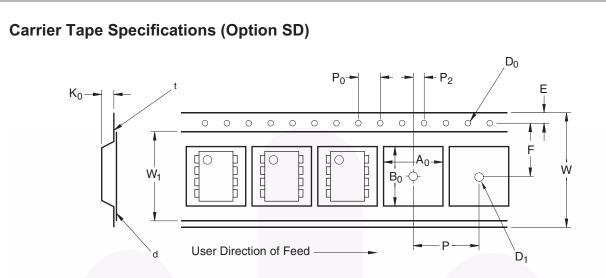


Definiti	Definitions					
1	Fairchild logo					
2	Device number					
3	VDE mark (Note: Only appears on parts ordered with VDE option – See order entry table) (pending approval)					
4	Two digit year code, e.g., '07'					
5	Two digit work week ranging from '01' to '53'					
6	Assembly package code					

### Note:

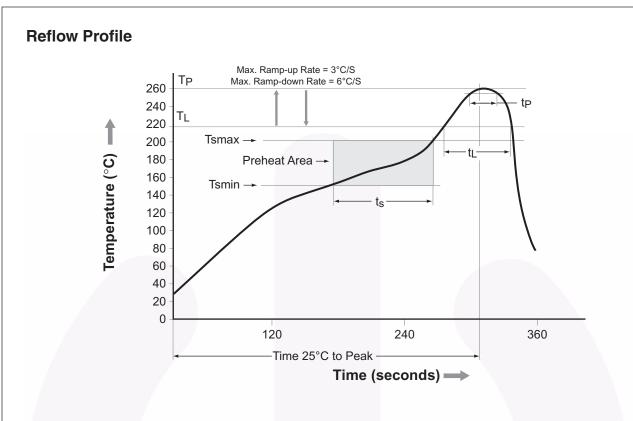
'HCPL' devices are marked only with the numerical characters (for example, HCPL2630 is marked as '2630').

The 'M' suffix on the part number is an order identifier only. It is used to identify orders for the white package version. The 'M' does not appear on the device's top mark.



Symbol	Description	Dimension in mm
W	Tape Width	16.0 ± 0.3
t	Tape Thickness	$0.30 \pm 0.05$
P <sub>0</sub>	Sprocket Hole Pitch	4.0 ± 0.1
D <sub>0</sub>	Sprocket Hole Diameter	1.55 ± 0.05
E	Sprocket Hole Location	1.75 ± 0.10
F	Pocket Location	7.5 ± 0.1
P <sub>2</sub>		2.0 ± 0.1
Р	Pocket Pitch	12.0 ± 0.1
A <sub>0</sub>	Pocket Dimensions	10.30 ±0.20
B <sub>0</sub>		10.30 ±0.20
K <sub>0</sub>		4.90 ±0.20
W <sub>1</sub>	Cover Tape Width	13.2 ± 0.2
d	Cover Tape Thickness	0.1 max
	Max. Component Rotation or Tilt	10°
R	Min. Bending Radius	30

Single-Channel: 6N137M, HCPL2601M, HCPL2611M Dual-Channel: HCPL2630M, HCPL2631M (Preliminary) — High Speed 10MBit/s Logic Gate Optocouplers



Profile Freature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (t <sub>S</sub> ) from (Tsmin to Tsmax)	60–120 seconds
Ramp-up Rate (t <sub>L</sub> to t <sub>P</sub> )	3°C/second max.
Liquidous Temperature (T <sub>L</sub> )	217°C
Time (t <sub>L</sub> ) Maintained Above (T <sub>L</sub> )	60–150 seconds
Peak Body Package Temperature	260°C +0°C / -5°C
Time (t <sub>P</sub> ) within 5°C of 260°C	30 seconds
Ramp-down Rate $(T_P \text{ to } T_L)$	6°C/second max.
Time 25°C to Peak Temperature	8 minutes max.



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PDP SPM™ Power-SPM™		
	Global Power Resource <sup>SM</sup> Green FPS™ e-Series™ Gmax™ GTO™ IntelliMAX™ ISOPLANAR™ MegaBuck™ MICROCOUPLER™ MicroFET™ MicroFET™ MicroFak2™ MillerDrive™ MotionMax™ Motion-SPM™ OptoHiT™ OPTOLOGIC® OPTOPLANAR®	Global Power Resource <sup>SM</sup> PowerXS™         Green FPS™ e-Series™       QFET <sup>®</sup> Gmax™       QS™         GTO™       Quiet Series™         IntelliMAX™       RapidConfigure™         ISOPLANAR™       OTM         MicroFET™       Saving our world, 1mW/W/kW at a time™         MicroFET™       Saving our world, 1mW/W/kW at a time™         MicroFet™       Saving our world, 1mW/W/kW at a time™         MicroPak™       SmartMax™         MicroPak™       SmartMax™         MicroPak™       StEALTH™         Motion-SPM™       SuperSOT™-8         OptoHiT™       SuperSOT™-8         OPTOPLANAR®       SuperMoS™         SyncFET™       Sync-Lock™

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As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties awill appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

#### PRODUCT STATUS DEFINITIONS

Definition of Terms		
Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.